

MS40N06 60V N-Channel MOSFET

GENERAL DESCRIPTION

The MS40N06 is the highest performance trench N-ch MOSFETs with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications . The QM6006M6 meet the RoHS and Green Product requirement , 100% EAS guaranteed with full function reliability approved.

FEATURES

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available



RoHS COMPLIANT

HALOGEN FREE Avaliable

Symbol	Parameter	Rating		Units
VDS	Drain-Source Voltage	60	v	
VGS	Gate-Source Voltage	±20	v	
ID@TC=25°C	Continuous Drain Current, VGS @ 10V ¹	40		А
ID@TC=100°C	Continuous Drain Current, VGS @ 10V ¹	25		А
ID@TA=25°C	Continuous Drain Current, VGS @ 10V ¹	7.4		А
ID@TA=70°C	Continuous Drain Current, VGS @ 10V ¹	6		А
IDM	Pulsed Drain Current ²	80		А
EAS	Single Pulse Avalanche Energy ³	67		m
LA3	Single Fuise Avalanche Energy			J
IAS	Avalanche Current	28		А
PD@TC=25°C	Total Power Dissipation ⁴	59		w
PD@TA=25°C	Total Power Dissipation ⁴	2		w
TSTG	Storage Temperature Range	-55 to 150		°C
TJ	Operating Junction Temperature Range	-55 to 150		°C
Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction-Ambient ¹		62	°C/W
Rejc	Thermal Resistance Junction-Case ¹		2.1	°C/W



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	VGS=0V , ID=250uA	60			V
△BVDSS/△TJ	BVDSS Temperature Coefficient	Reference to 25°C, ID=1mA		0.057		V/°C
RDS(ON)	Static Drain-Source On-Resistance ²	VGS=10V , ID=30A		14	18	mΩ
		VGS=4.5V , ID=15A		16	20	
VGS(th)	Gate Threshold Voltage	VGS=VDS , ID =250uA	1.2		2.5	V
△VGS(th)	VGS(th) Temperature Coefficient			-5.68		mV/°C
IDSS	Drain-Source Leakage Current	VDS=48V, VGS=0V, TJ=25°C			1	uA
		VDS=48V , VGS=0V , TJ=55°C			5	
IGSS	Gate-Source Leakage Current	VGS=±20V, VDS=0V			±100	nA
gfs	Forward Transconductance	VDS=5V , ID=30A		35.2		S
Rg	Gate Resistance	VDS=0V , VGS=0V , f=1MHz		1.7	3.4	Ω
Qg	Total Gate Charge (4.5V)			19.3	27	nC
Qgs	Gate-Source Charge	VDS=48V , VGS=4.5V , ID=15A		7.1	10	
Qgd	Gate-Drain Charge			7.6	10.6	
Td(on)	Turn-On Delay Time			7.2	14.4	
Tr	Rise Time	VDD=30V , VGS=10V ,		50	90	ns
Td(off)	Turn-Off Delay Time	RG=3.3Ω, ID=15A		36.4	73	
Tf	Fall Time			7.6	15.2	
Ciss	Input Capacitance			2423	3392	
Coss	Output Capacitance	VDS=15V , VGS=0V , f=1MHz		145	203	pF
Crss	Reverse Transfer Capacitance			97	136	
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	VDD=25V , L=0.1mH , IAS=15A	19			mJ
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit

IS	Continuous Source Current ^{1,6}	VG=VD=0V , Force Current	 	40	А
ISM	Pulsed Source Current ^{2,6}		 	80	А
VSD	Diode Forward Voltage ²	VGS=0V , IS=A , TJ=25°C	 	1	V
trr	Reverse Recovery Time	IF=15A , dl/dt=100A/µs , TJ=25°C	 16.3		nS
Qrr	Reverse Recovery Charge		 11		nC

Note :

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- The EAS data shows Max. rating . The test condition is VDD=25V,VGS=10V,L=0.1mH,IAS=28A
 The power dissipation is limited by 150°C junction temperature
- 5. The Min. value is 100% EAS tested guarantee.
- The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.



Characteristic Curves

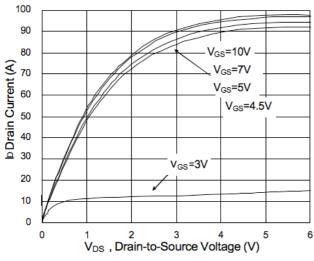
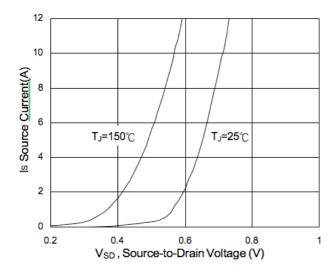


Figure 1. Typical Output Characteristics





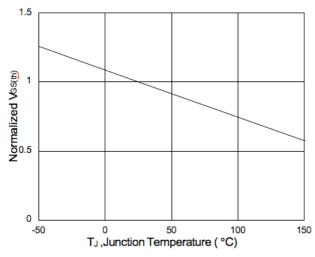


Figure 5. Normalized VGS(th) v.s TJ

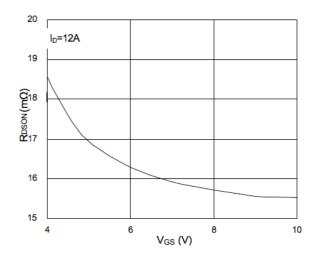


Figure 2. On-Resistance v.s **Gate-Source**

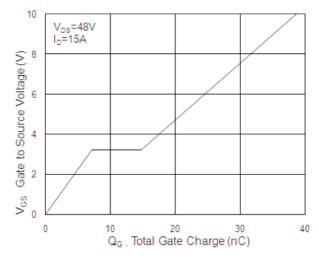


Figure 4. Gate-Charge Characteristics

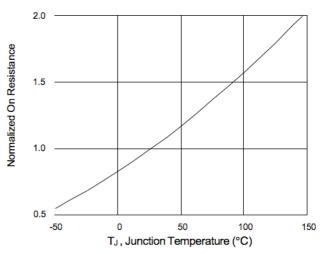


Figure 6. Normalized RDSON v.s TJ



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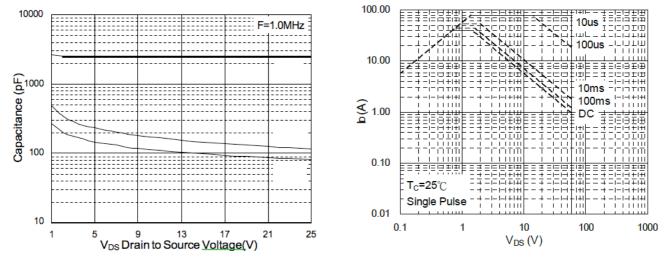


Figure 7. Capacitance

Figure 8. Safe Operating Area

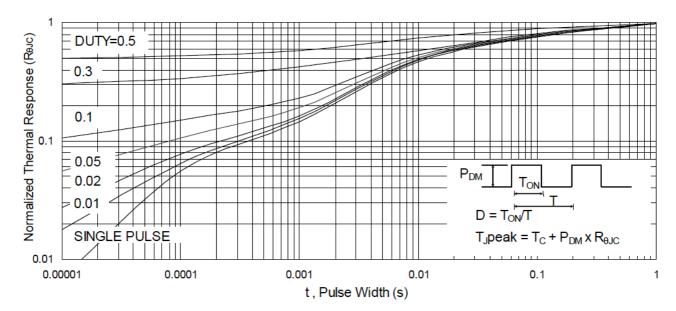
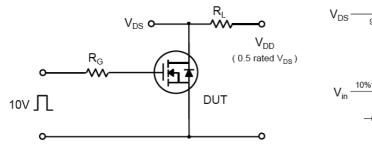


Figure 9. Normalized Maximum Transient Thermal Impedance



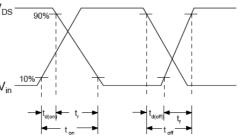
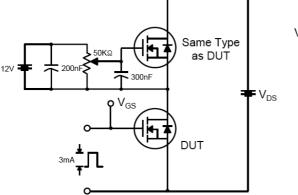
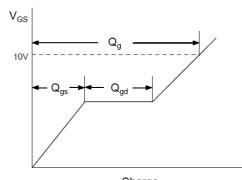


Fig 10. Resistive Switching Test Circuit & Waveforms



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Charge

Fig 11. Gate Charge Test Circuit & Waveform

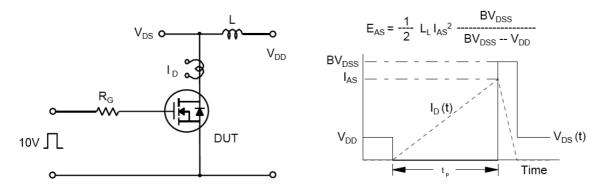
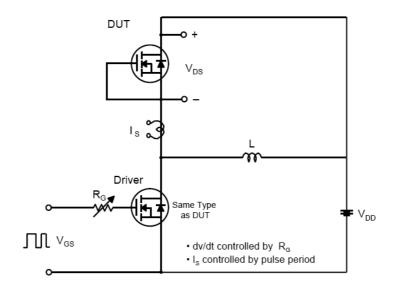
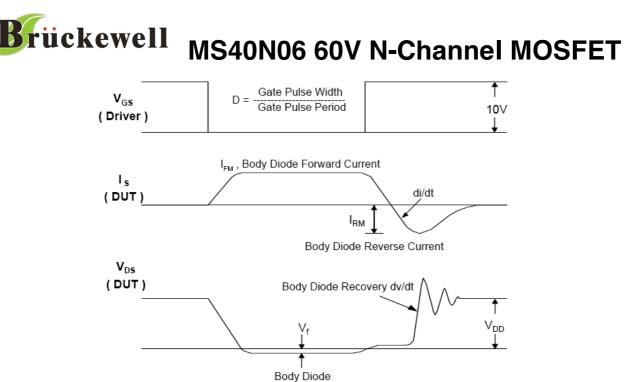


Fig 12. Unclamped Inductive Switching Test Circuit & Waveforms





Forward Voltage Drop

Fig 131. Peak Diode Recovery dv/dt Test Circuit & Waveforms



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